

C3M0045065L

Silicon Carbide Power MOSFET

C3M™ MOSFET Technology

N-Channel Enhancement Mode

Features

- 3rd generation SiC MOSFET technology
- Optimized package with separate driver source pin
- High blocking voltage with low on-resistance
- High-speed switching with low capacitances
- Fast intrinsic diode with low reverse recovery (Q_{rr})
- Halogen free, RoHS compliant

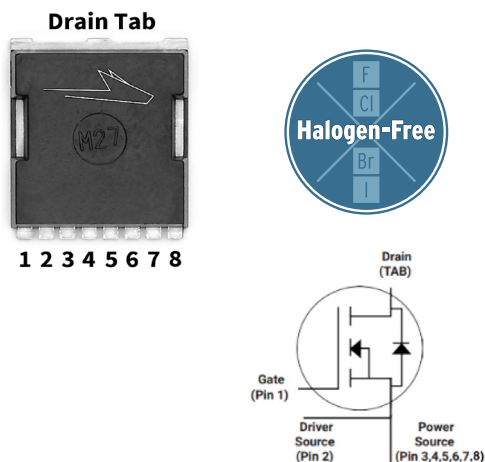
Benefits

- Reduce switching losses and minimize gate ringing
- Higher system efficiency
- Reduce cooling requirements
- Increase power density
- Increase system switching frequency

Applications

- Datacenter Power Supplies
- Telecom Power Supplies
- Energy Storage Systems
- Solar (PV) inverters
- High Voltage DC/DC converters

Package



Orderable Part Number	Package	Marking
C3M0045065L-TR	TOLL	C3M0045065L

Maximum Ratings ($T_c = 25^\circ\text{C}$ unless otherwise specified)

Symbol	Parameter		Value	Unit	Note
V_{DSmax}	Drain - Source Voltage		650	V	
V_{GSmax}	Gate - Source Voltage		-8/+19	V	Note: 1
I_D	Continuous Drain Current, $V_{GS} = 15\text{ V}$	$T_c = 25^\circ\text{C}$	49	A	Fig. 19 Note: 2
		$T_c = 100^\circ\text{C}$	33		
$I_{D(pulse)}$	Pulsed Drain Current, Pulse width t_p limited by T_{jmax}		132	A	Fig. 22
P_D	Power Dissipation, $T_c=25^\circ\text{C}$, $T_j = 175^\circ\text{C}$		164	W	Fig. 20 Note: 2
T_j	Junction Temperature		-40 to +175	$^\circ\text{C}$	
T_c, T_{stg}	Case Temperature and Storage Temperature		-40 to +150	$^\circ\text{C}$	
T_L	Solder Temperature, 1.6mm (0.063") from case for 10s		260	$^\circ\text{C}$	

Note (1): Recommended turn off / turn on gate voltage $V_{GS} = -4V...0V / +15V$

Note (2): Verified by design


Electrical Characteristics ($T_C = 25^\circ\text{C}$ unless otherwise specified)

Symbol	Parameter	Min.	Typ.	Max.	Unit	Test Conditions	Note
$V_{(BR)DSS}$	Drain-Source Breakdown Voltage	650			V	$V_{GS} = 0\text{ V}, I_D = 100\text{ }\mu\text{A}$	
$V_{GS(th)}$	Gate Threshold Voltage	1.8	2.6	3.6	V	$V_{DS} = V_{GS}, I_D = 4.84\text{ mA}$	Fig. 11
			2.2		V	$V_{DS} = V_{GS}, I_D = 4.84\text{ mA}, T_J = 175^\circ\text{C}$	
I_{DSS}	Zero Gate Voltage Drain Current		1	50	μA	$V_{DS} = 650\text{ V}, V_{GS} = 0\text{ V}$	
I_{GSS}	Gate-Source Leakage Current		10	250	nA	$V_{GS} = 15\text{ V}, V_{DS} = 0\text{ V}$	
$R_{DS(on)}$	Drain-Source On-State Resistance		45	60	m Ω	$V_{GS} = 15\text{ V}, I_D = 17.6\text{ A}$	Fig. 4, 5, 6
			61			$V_{GS} = 15\text{ V}, I_D = 17.6\text{ A}, T_J = 175^\circ\text{C}$	
g_{fs}	Transconductance		12		S	$V_{DS} = 20\text{ V}, I_{DS} = 17.6\text{ A}$	Fig. 7
			11			$V_{DS} = 20\text{ V}, I_{DS} = 17.6\text{ A}, T_J = 175^\circ\text{C}$	
C_{iss}	Input Capacitance		1621		pF	$V_{GS} = 0\text{ V}, V_{DS} = 400\text{ V}$ $F = 1\text{ MHz}$ $V_{AC} = 25\text{ mV}$	Fig. 17, 18
C_{oss}	Output Capacitance		101				
C_{rss}	Reverse Transfer Capacitance		8				
E_{oss}	C_{oss} Stored Energy		20		μJ	$V_{DS} = 600\text{ V}, F = 1\text{ MHz}$	
$C_{o(er)}$	Effective Output Capacitance (Energy Related)		126		pF	$V_{GS} = 0\text{ V}, V_{DS} = 0 \dots 400\text{ V}$	Note: 3
$C_{o(tr)}$	Effective Output Capacitance (Time Related)		178		pF		
E_{ON}	Turn-On Switching Energy (Body Diode FWD)		53		μJ	$V_{DS} = 400\text{ V}, V_{GS} = -4\text{ V}/15\text{ V}, I_D = 17.6\text{ A},$ $R_{G(ext)} = 2.5\text{ }\Omega, L = 99\text{ }\mu\text{H}, T_J = 25^\circ\text{C}$ FWD = Internal Body Diode	Fig. 23
E_{OFF}	Turn-Off Switching Energy (Body Diode FWD)		10				
$t_{d(on)}$	Turn-On Delay Time		7		ns	$V_{DD} = 400\text{ V}, V_{GS} = -4\text{ V}/15\text{ V}$ $I_D = 17.6\text{ A}, R_{G(ext)} = 2.5\text{ }\Omega,$ Timing relative to V_{DS} Inductive load	Fig. 26
t_r	Rise Time		9				
$t_{d(off)}$	Turn-Off Delay Time		17				
t_f	Fall Time		6				
$R_{G(int)}$	Internal Gate Resistance		3		Ω	$f = 1\text{ MHz}, V_{AC} = 25\text{ mV}$	
Q_{gs}	Gate to Source Charge		20		nC	$V_{DS} = 400\text{ V}, V_{GS} = -4\text{ V}/15\text{ V}$ $I_D = 17.6\text{ A}$ Per IEC60747-8-4 pg 21	Fig. 12
Q_{gd}	Gate to Drain Charge		16				
Q_g	Total Gate Charge		59				

Note (3): $C_{o(er)}$, a lumped capacitance that gives same stored energy as C_{oss} while V_{ds} is rising from 0 to 400V

$C_{o(tr)}$, a lumped capacitance that gives same charging time as C_{oss} while V_{ds} is rising from 0 to 400V


Reverse Diode Characteristics ($T_c = 25^\circ\text{C}$ unless otherwise specified)

Symbol	Parameter	Typ.	Max.	Unit	Test Conditions	Note
V_{SD}	Diode Forward Voltage	4.8		V	$V_{GS} = -4\text{ V}, I_{SD} = 8.8\text{ A}, T_J = 25^\circ\text{C}$	Fig. 8, 9, 10
		4.2		V	$V_{GS} = -4\text{ V}, I_{SD} = 8.8\text{ A}, T_J = 175^\circ\text{C}$	
I_S	Continuous Diode Forward Current		28	A	$V_{GS} = -4\text{ V}, T_c = 25^\circ\text{C}$	
$I_{S, \text{pulse}}$	Diode pulse Current		132	A	$V_{GS} = -4\text{ V}$, pulse width t_p limited by T_{Jmax}	
t_{rr}	Reverse Recover time	10		ns	$V_{GS} = -4\text{ V}, I_{SD} = 17.6\text{ A}, V_R = 400\text{ V}$ $dif/dt = 6580\text{ A}/\mu\text{s}, T_J = 25^\circ\text{C}$	
Q_{rr}	Reverse Recovery Charge	207		nC		
I_{rrm}	Peak Reverse Recovery Current	38		A		
t_{rr}	Reverse Recover time	12		ns	$V_{GS} = -4\text{ V}, I_{SD} = 17.6\text{ A}, V_R = 400\text{ V}$ $dif/dt = 2260\text{ A}/\mu\text{s}, T_J = 25^\circ\text{C}$	
Q_{rr}	Reverse Recovery Charge	94		nC		
I_{rrm}	Peak Reverse Recovery Current	14		A		

Thermal Characteristics

Symbol	Parameter	Typ.	Unit	Test Conditions	Note
$R_{\theta JC}$	Thermal Resistance from Junction to Case	0.64	$^\circ\text{C}/\text{W}$		Fig. 21



Typical Performance

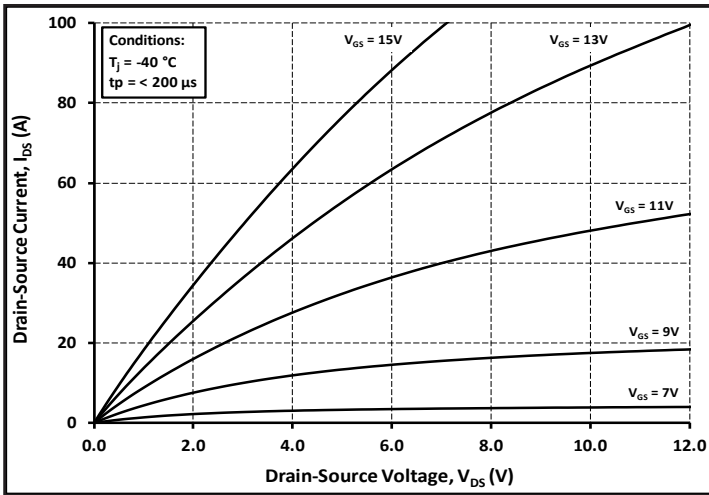


Figure 1. Output Characteristics $T_J = -40\text{ }^{\circ}\text{C}$

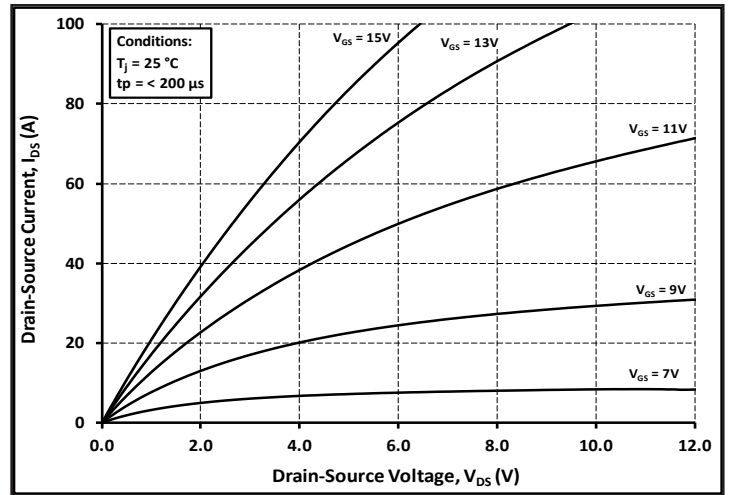


Figure 2. Output Characteristics $T_J = 25\text{ }^{\circ}\text{C}$

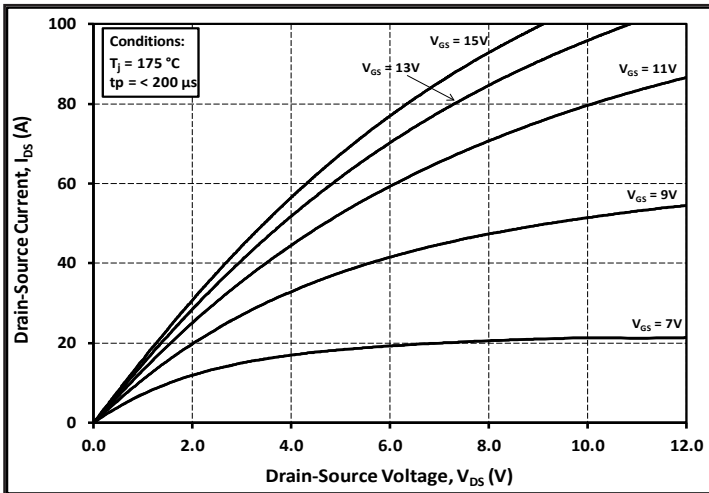


Figure 3. Output Characteristics $T_J = 175\text{ }^{\circ}\text{C}$

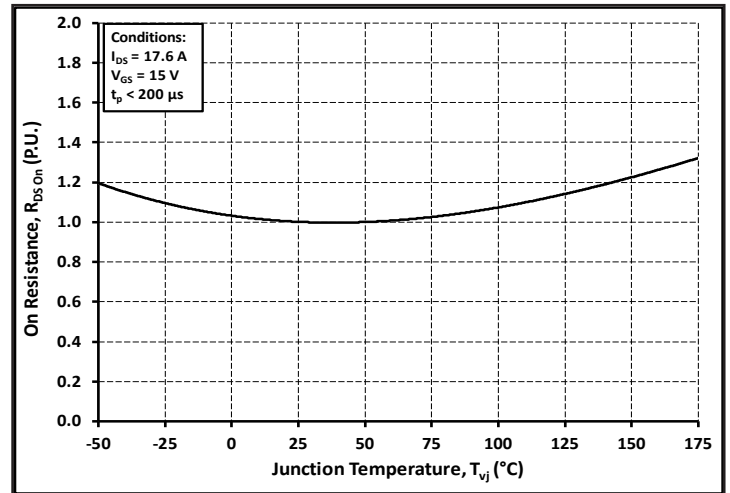


Figure 4. Normalized On-Resistance vs. Temperature

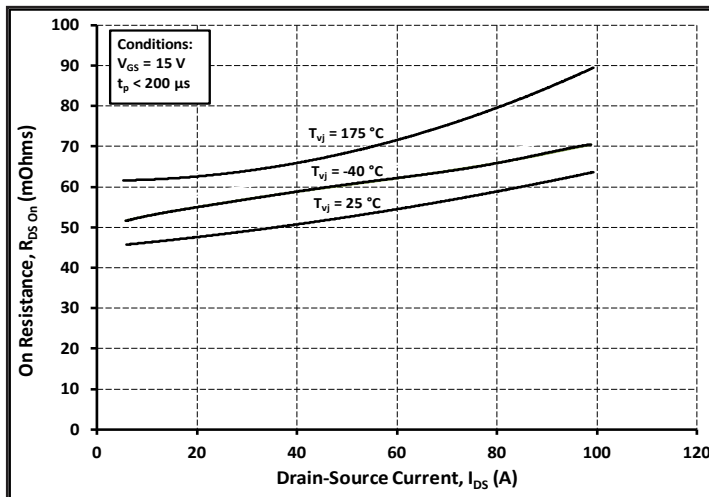


Figure 5. On-Resistance vs. Drain Current
For Various Temperatures

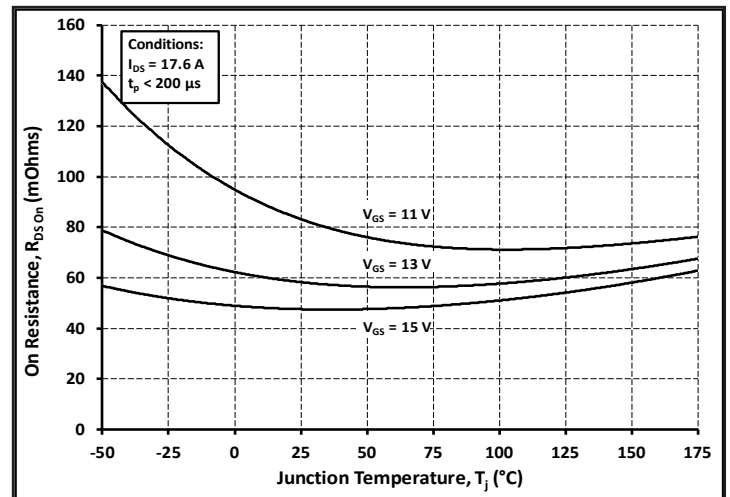


Figure 6. On-Resistance vs. Temperature
For Various Gate Voltage

Typical Performance

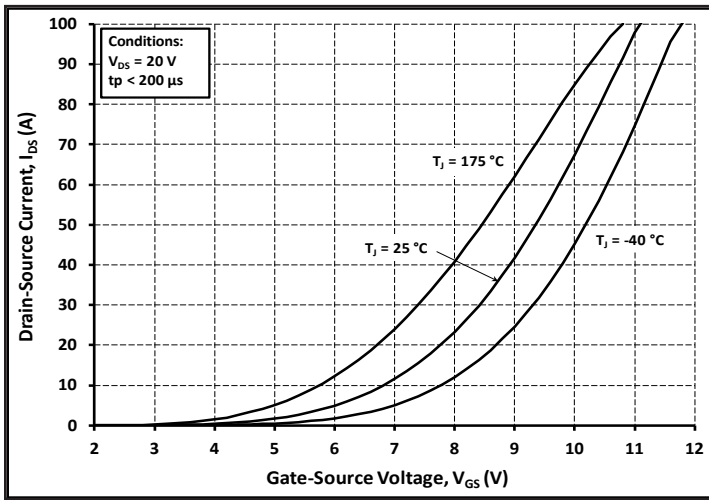


Figure 7. Transfer Characteristic for Various Junction Temperatures

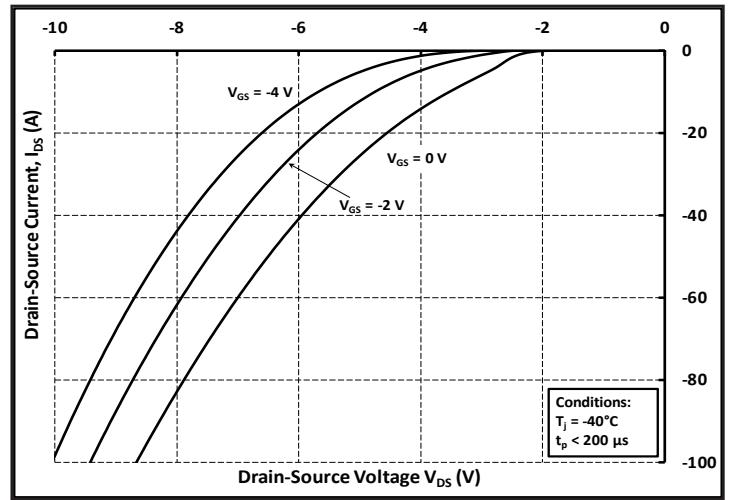


Figure 8. Body Diode Characteristic at -40 °C

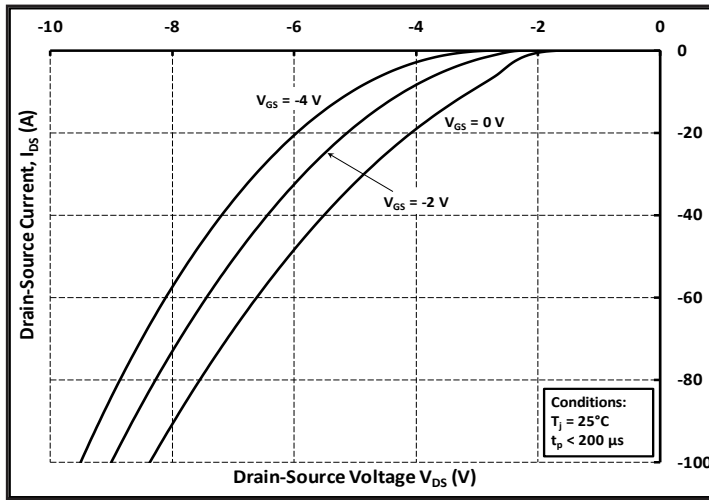


Figure 9. Body Diode Characteristic at 25 °C

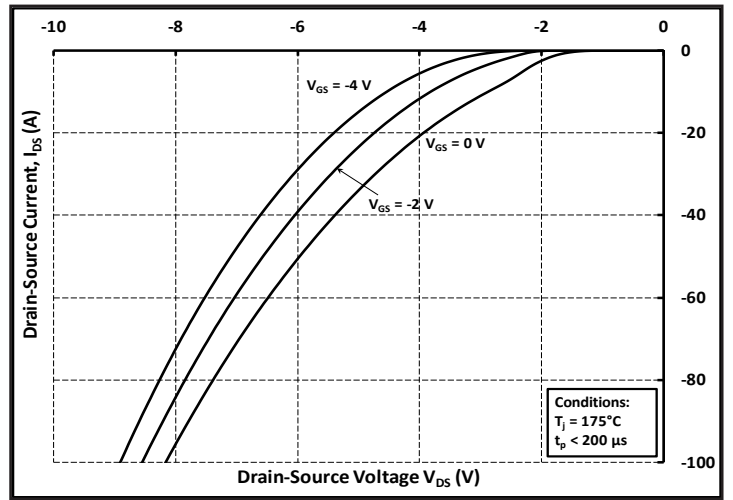


Figure 10. Body Diode Characteristic at 175 °C

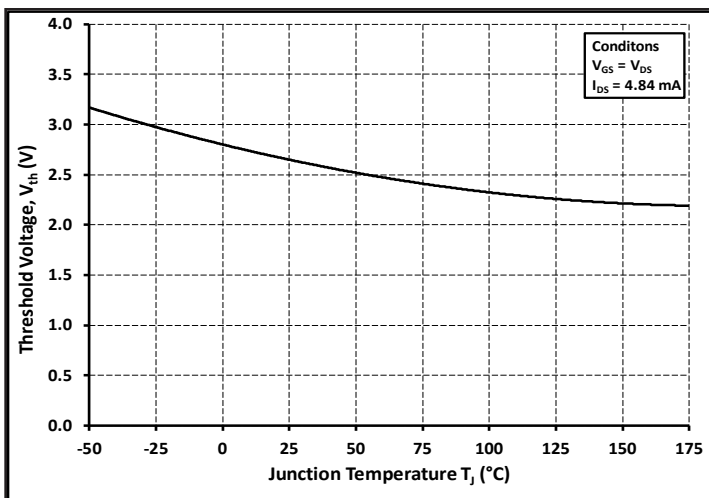


Figure 11. Threshold Voltage vs. Temperature

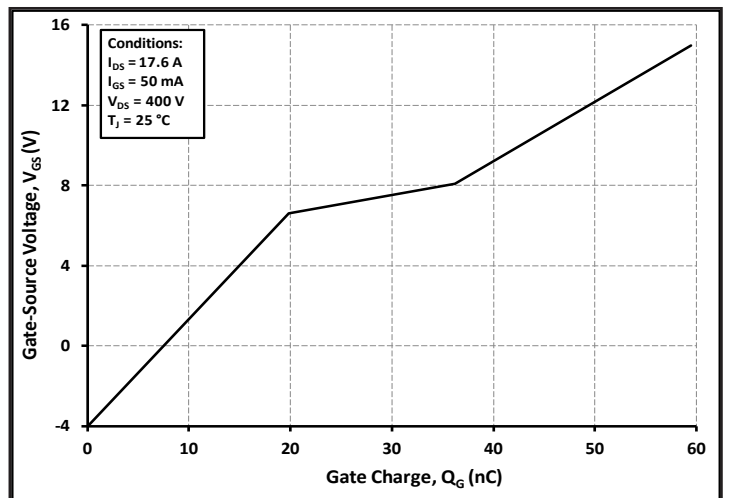


Figure 12. Gate Charge Characteristics

Typical Performance

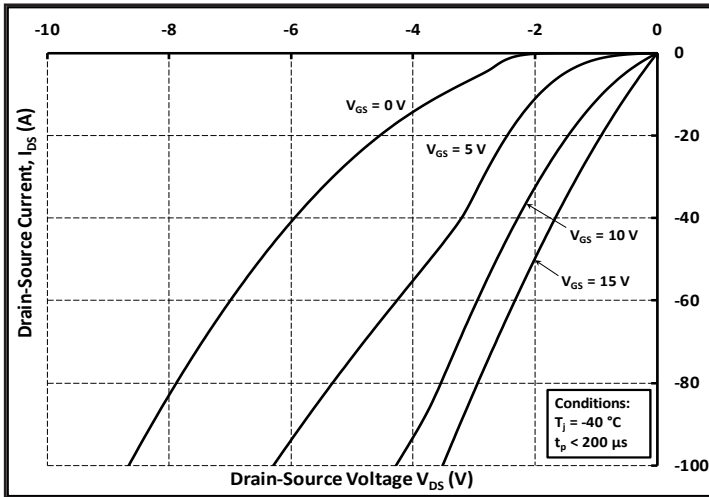
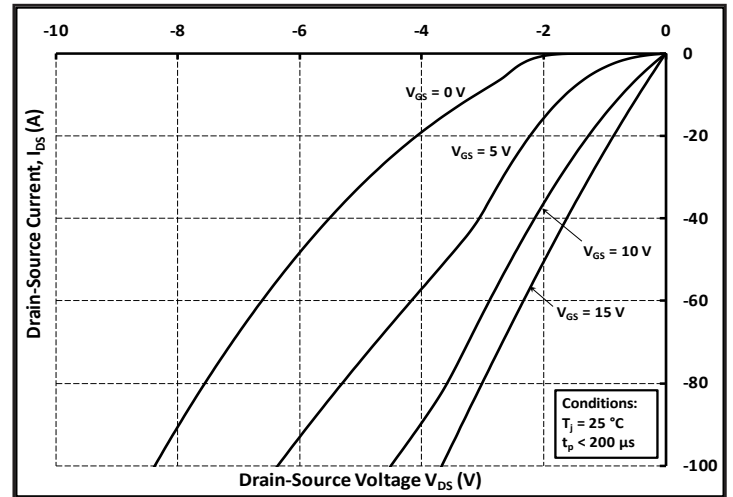
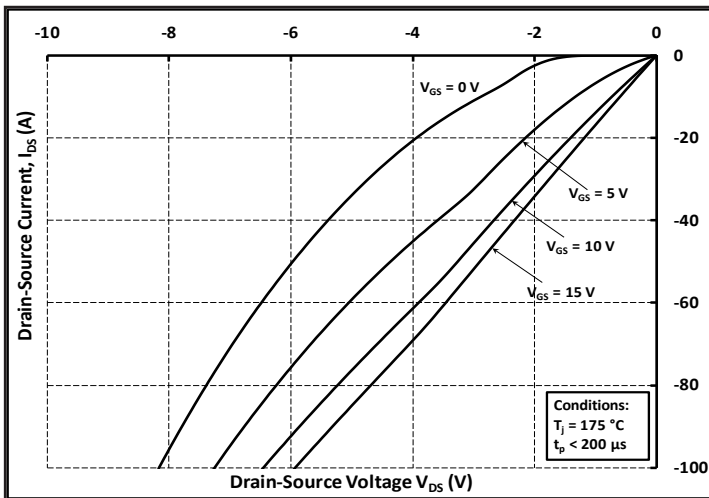
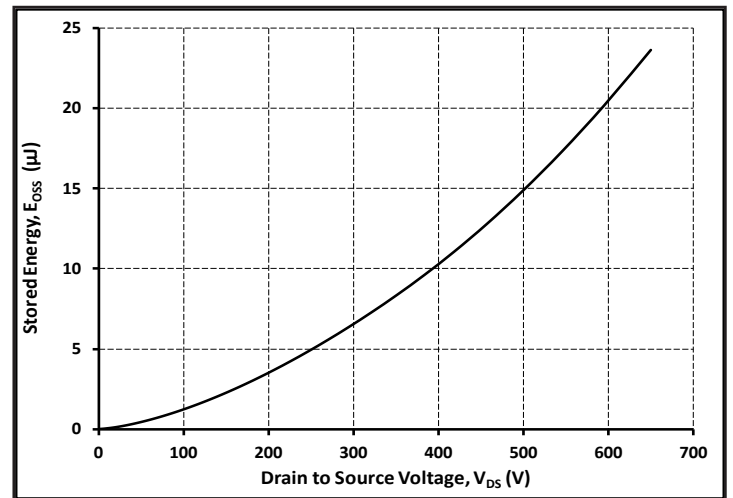
Figure 13. 3rd Quadrant Characteristic at $-40\text{ }^{\circ}\text{C}$ Figure 14. 3rd Quadrant Characteristic at $25\text{ }^{\circ}\text{C}$ Figure 15. 3rd Quadrant Characteristic at $175\text{ }^{\circ}\text{C}$ 

Figure 16. Output Capacitor Stored Energy

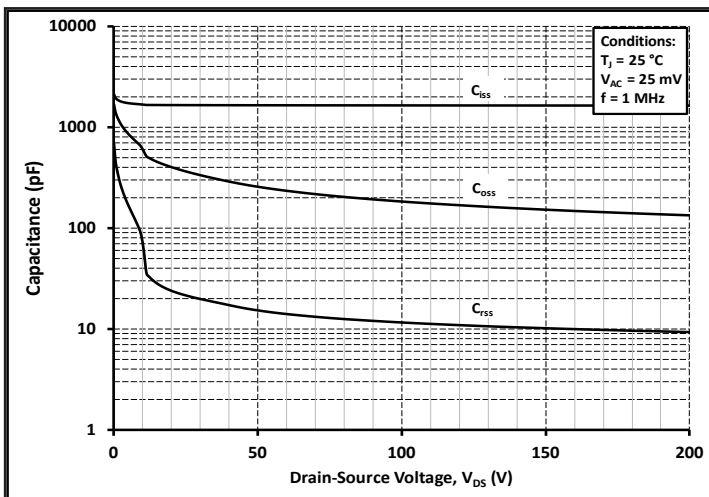


Figure 17. Capacitances vs. Drain-Source Voltage (0 - 200V)

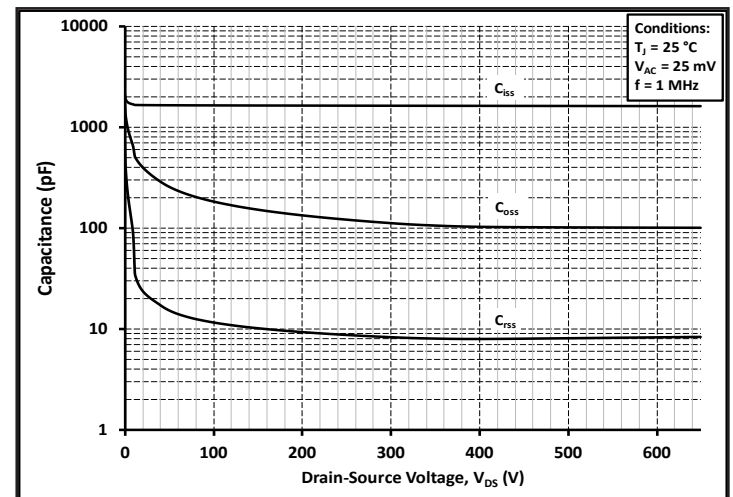


Figure 18. Capacitances vs. Drain-Source Voltage (0 - 650V)

Typical Performance

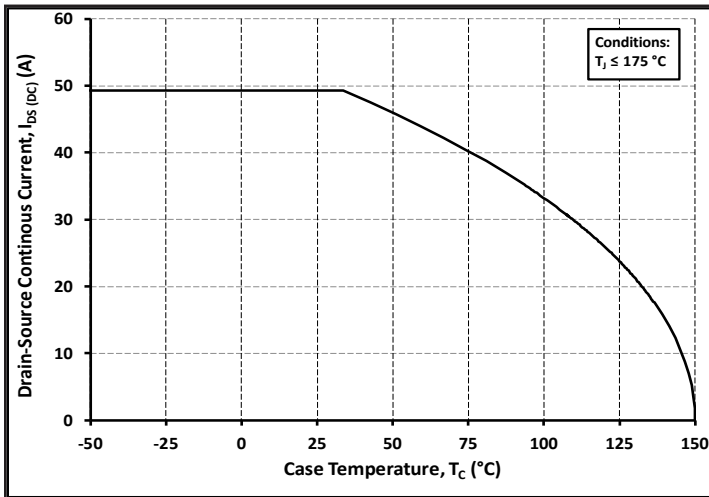


Figure 19. Continuous Drain Current Derating vs. Case Temperature

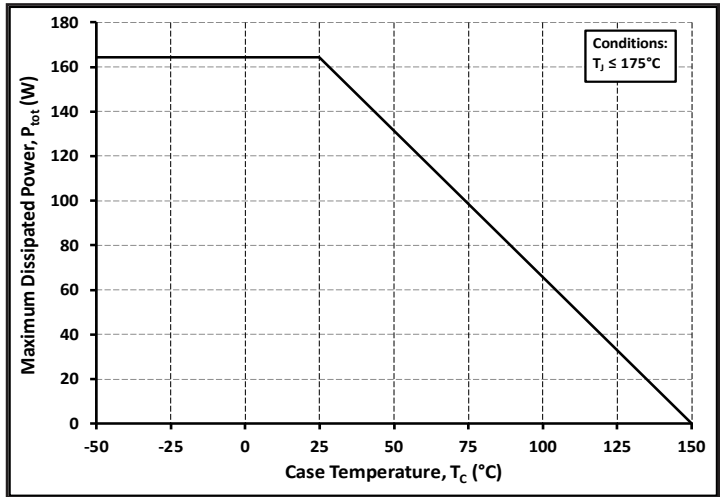


Figure 20. Maximum Power Dissipation Derating vs. Case Temperature

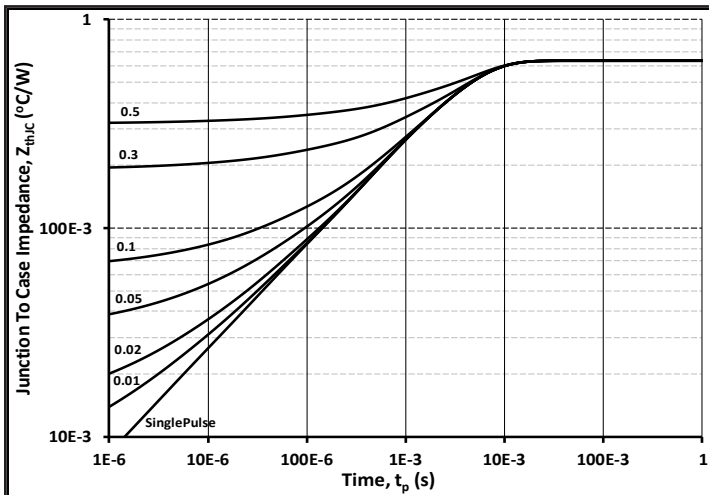


Figure 21. Transient Thermal Impedance (Junction - Case)

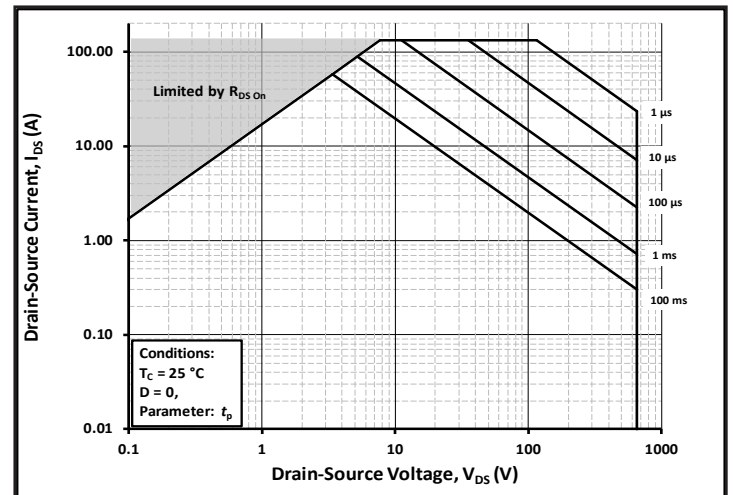


Figure 22. Safe Operating Area

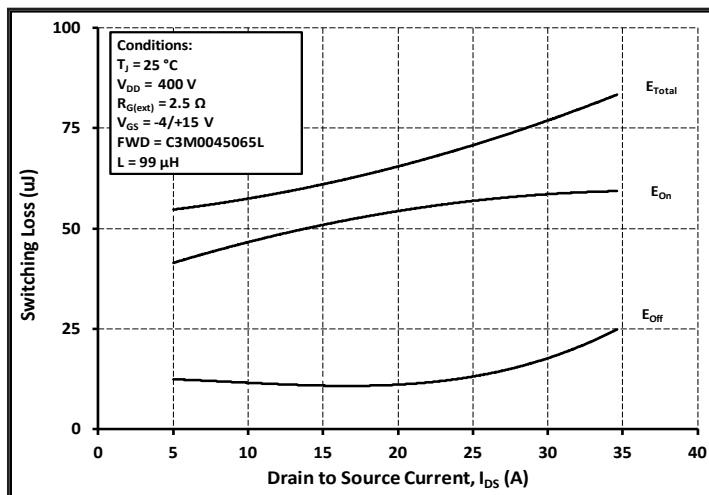


Figure 23. Clamped Inductive Switching Energy vs. Drain Current ($V_{DD} = 400V$)

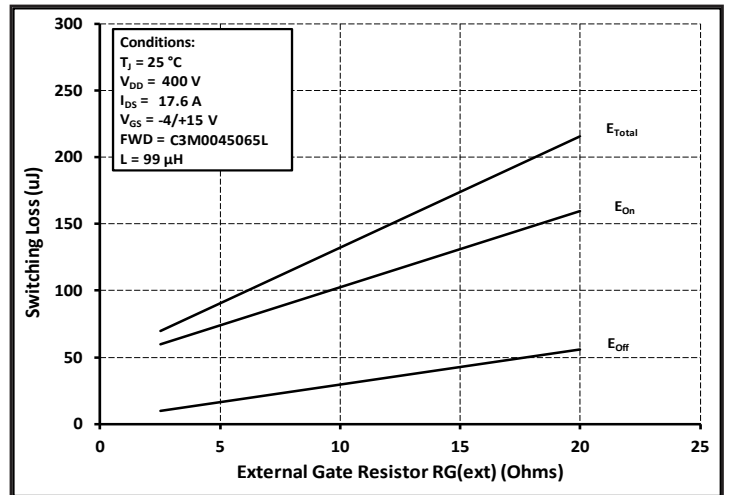


Figure 24. Clamped Inductive Switching Energy vs. $R_{G(ext)}$



Typical Performance

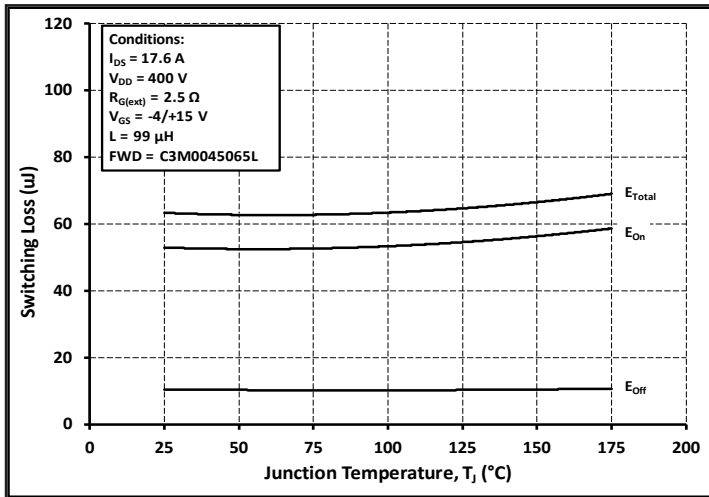


Figure 25. Clamped Inductive Switching Energy vs. Temperature

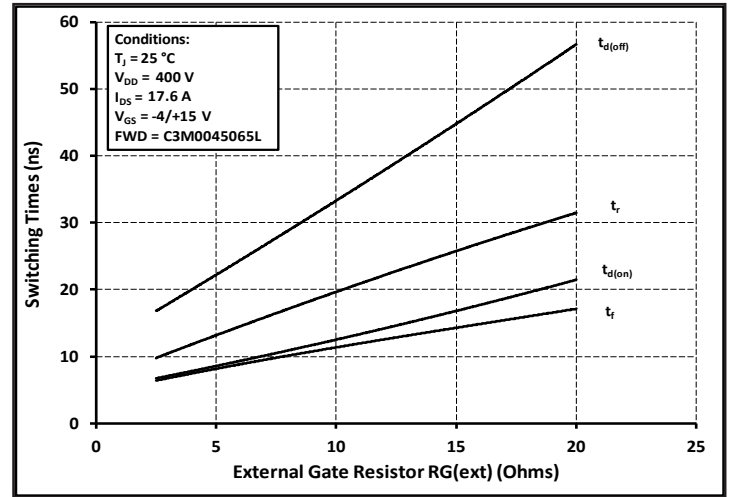


Figure 26. Switching Times vs. $R_{G(ext)}$

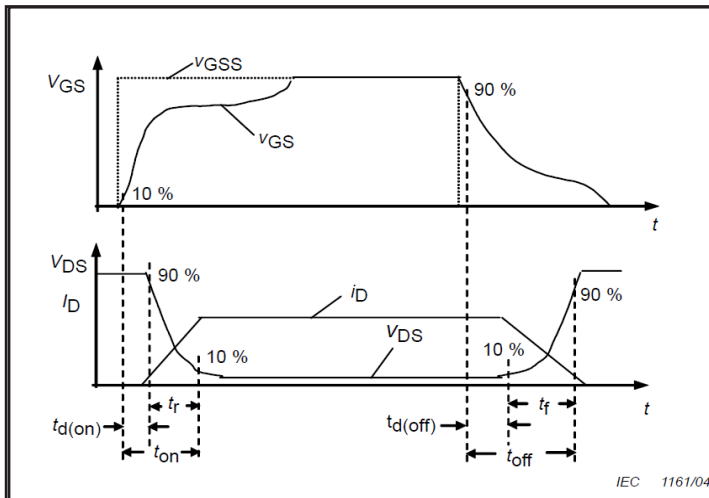


Figure 27. Switching Times Definition

Test Circuit Schematic

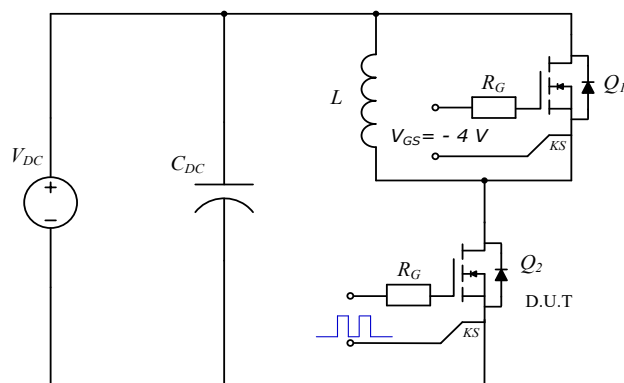
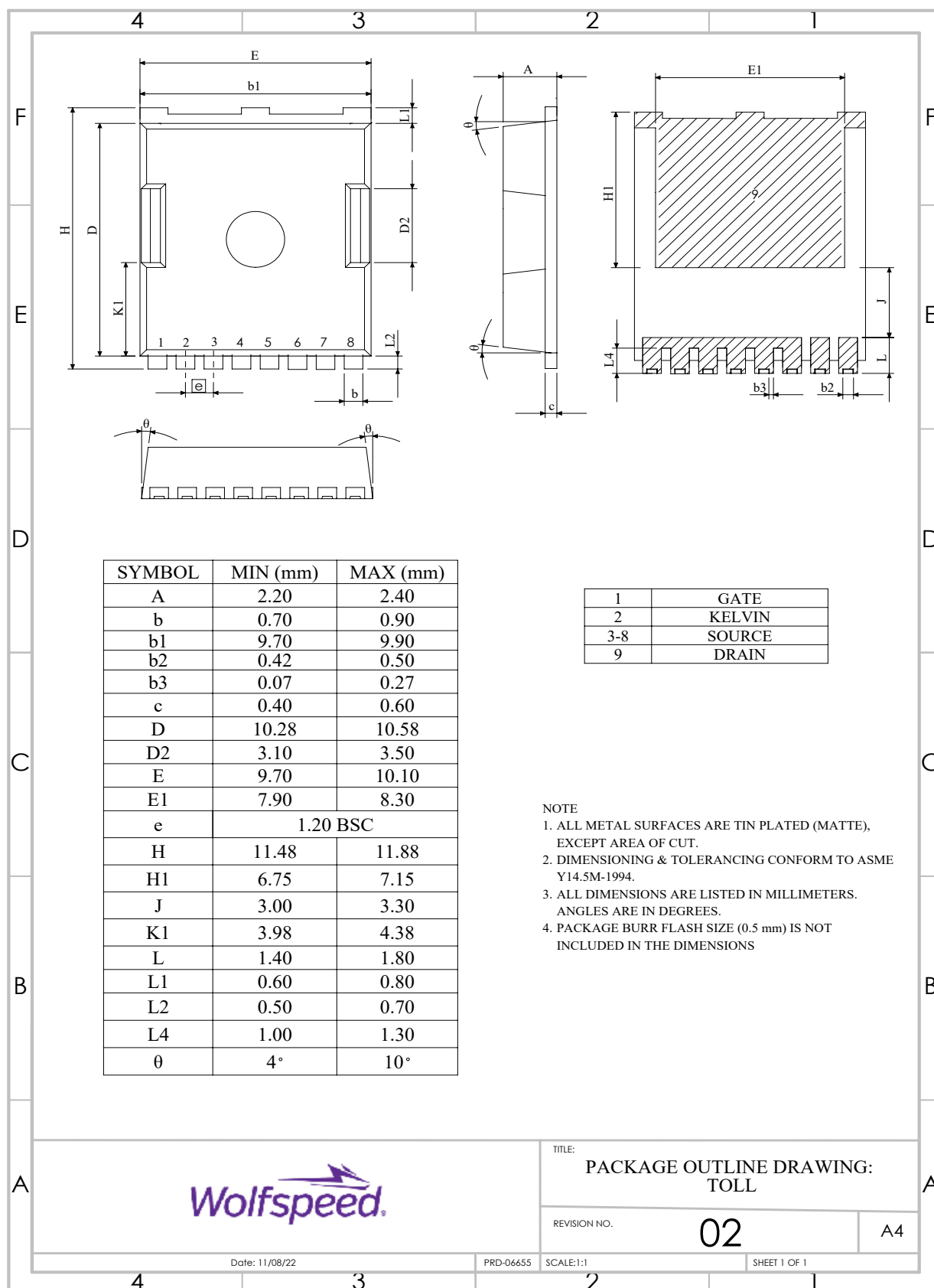


Figure 28. Clamped Inductive Switching
Waveform Test Circuit

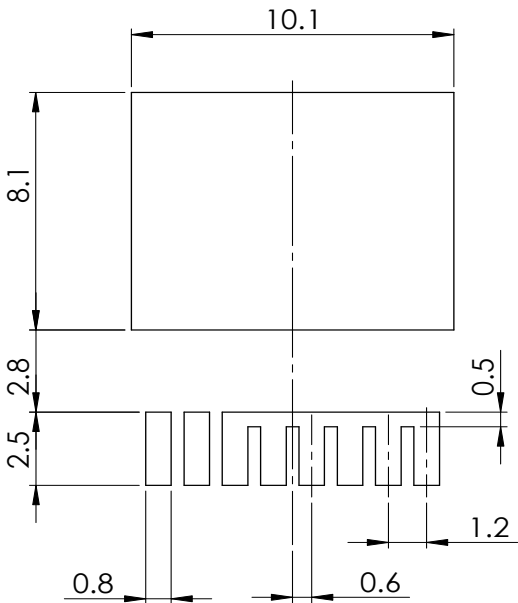
Package Dimensions





Recommended Solder Pad Layout

(Note: All Dimensions are listed in Millimeters)





Revision history

Document Version	Date of release	Description of changes
1.0	September-2022	Initial datasheet
2.0	November-2022	Correction in the placement of "E1" package dimension Orderable part number information added



Notes & Disclaimer

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